

Search Notes

Application/Control No.

10/767,171

Examiner

Susan F. Rayyan

Applicant(s)/Patent under
Reexamination

SHIMIZU ET AL.

Art Unit

2167

SEARCHED

Class	Subclass	Date	Examiner
707	10,102 104.1	1/6/2007	SR
725	60,61	1/6/2007	SR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	1/6/2007	SR
IEEE	1/6/2007	SR
Inventor's Name Search	1/6/2007	SR